

**Notice of References Cited**

Application/Control No.

10/553,469

Applicant(s)/Patent Under

Reexamination

FUJII ET AL.

Examiner

ATIBA O. FITZPATRICK

Art Unit

2624

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,425,081	07-2002	Iwamura, Keiichi	713/176
B	US-			
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D	US-			
E	US-			
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**FOREIGN PATENT DOCUMENTS**

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